Search Notes



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SHEN ET AL.

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Art Unit

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SEARCHED

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SEARCH NOTES

Search Notes	Date	Examiner
East USPat PGPub EPO JPO Derwent, see printout	11/26/07	MM
Medline, see printouts	11/28/07	ii
Seq 4-10, see SCORE		STIC
Inventor search	11/28/07	MM

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